## **AMENDMENTS TO THE CLAIMS:**

This listing of claims will replace all prior versions, and listings, of claims in the application:

## **LISTING OF CLAIMS:**

1. (Currently Amended) A reflector <u>comprising a reflective layer</u> having a laminate structure of at least a high refractive index layer (A), a low refractive index layer (B), <u>and</u> a metal layer (C) mainly composed of a metal selected from silver or <u>aluminum</u>, <u>aluminum</u>; and a polymer base (D),

wherein the layer (A), the layer (B) and the layer (C) are laminated in the order of (A)/(B)/(C), and

wherein the polymer base (D) satisfies the following condition (I),

- (I) the content (Rn) of atoms of the same elements as elements (A2) (excluding metals) in elements (A1) (excluding metals) relative to the elements (A1) is not less than 98.0 atomic %, wherein the elements (A1) are observed by the XPS measurement of portion at depths of 0 nm to 10 nm from a side of the reflective layer of the polymer base (D) and the elements (A2) are observed by the XPS measurement of portion at depths of 50 nm to 10  $\mu$ m from a side of the reflective layer of the polymer base (D).
- 2. (Original) The reflector according to claim 1, wherein the polymer base (D) is a polymer film.
- 3. (Original) A lamp reflector using the reflector as described in claim 1.

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- 4. (Original) A reflector under a light-guiding plate using the reflector as described in claim 1.
- 5. (Original) A backlight device using the reflector as described in claim 1.
- 6. (Original) A liquid crystal display using the reflector as described in claim 1.
- 7. (Previously Presented) A method for producing the reflector wherein a reflective layer having a laminate structure of a high refractive index layer (A), a low refractive index layer (B), and a metal layer (C) mainly composed of a metal selected from silver or aluminum is formed on a polymer base (D1) satisfying the following condition (II) in the order of (A)/(B)/(C),
- (II) the content (Rn<sub>1</sub>) of atoms of the same elements as elements (A21) (excluding metals) in elements (A11) (excluding metals) relative to the elements (A11) is not less than 98.0 atomic %, wherein the elements (A11) are observed by the XPS measurement of the surface forming a reflective layer of the polymer base (D1) and the elements (A21) are observed by the XPS measurement of portion at depths of 50 nm to 10  $\mu$ m from a side of the reflective layer of the appropriate surface of the polymer base (D1).
- 8. (Original) The method for producing the reflector according to claim 7, wherein the polymer base (D1) is a polymer base (D2) in which a polymer base and a liquid are subjected to coming into contact with each other.